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CERTIFICATE OF MAILING
37 CFR 1.8

I hereby certify that this correspondence is being deposited on
September 10, 2001 with the United States Postal Service as
First Class Mail in an envelope addressed to: Assistant
Commissioner for Patents, Washington, D.C. 20231.

9/10/01 B. Todd Patterson
Date Signature

Dear Sir:

The Applicants, and the Attorney who signs below on the basis of the information supplied by the inventor and the information in his file, submit herewith patents, publications, or other information of which they are aware, which may be material to the examination of this application and in respect of which there may be a duty to disclose in accordance with 37 CFR § 1.56.

While the information submitted in this Information Disclosure Statement may be material pursuant to 37 CFR § 1.56, it is not intended to constitute an admission that any patent, publication, or other information referred to therein is prior art for this invention unless specifically designated as such.

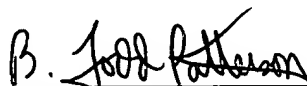
In accordance with 37 CFR § 1.97, this Information Disclosure Statement is not to be construed as a representation that a search has been made or that no other possibly material information as defined under 37 CFR § 1.56(a) exists.

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The patents and/or publications submitted herewith are set forth on the attached Form PTO-1449.

Applicant does not believe a fee is necessary, but if the fee of \$180.00 is due under 37 CFR § 1.17(p) pursuant to § 1.97, the Commissioner is hereby authorized to charge this fee, and any other fee necessary to make this submission timely, to the Deposit Account No. 20-0782/APPM/1570.C1/BTP.

Respectfully submitted,



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U.S. Department of Commerce, Patent and Trademark Office		Docket No.	Serial No.
(PTO Form 1449 modified)		APPM/1570.64	09/912,112
LIST OF PATENTS AND PUBLICATIONS CITED BY APPLICANT		Applicant Ishikawa, et al.	Confirmation No.:
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Examiner Unknown		July 23, 2001	Unknown

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U.S. Patent Documents							
*Examiner Initial		Document Number	Issue Date	Applicant(s) Name	Class	Subclass	Filing Date If Appropriate
	A1	6,189,483	02/20/2001	Ishikawa, et al.	118	723 E	05/29/1997
	A2	6,182,602	02/-6/2001	Redeker, et al.	118	723 R	05/29/1997
	A3	6,178,918	01/30/2001	Van Os, et al.	118	723 R	06/05/1998
	A4	6,170,428	01/09/2001	Redeker, et al.	118	723 I	07/15/1996
	A5	6,109,206	08/29/2000	Maydan, et al.	118	723 IR	05/29/1997
	A6	6,083,344	07/04/2000	Hanawa, et al.	156	345	05/29/1997
	A7	6,077,357	06/20/2000	Rossmann, et al.	118	728	05/29/1997
	A8	5,994,662	11/30/1999	Murugesh	219	121.43	05/29/1997
	A9	5,865,896	02/02/1999	Nowak, et al.	118	723 I	12/16/1996
	A10	5,792,272	08/11/1998	Van Os, et al.	118	723 IR	08/12/1997
	A11	5,707,692	01/13/1998	Suzuki	427	562	10/11/1994
	A12	5,681,418	10/28/1997	Ishimaru	156	345	08/30/1995
	A13	5,626,679	05/06/1997	Shimizu, et al.	118	723 MR	01/25/1995

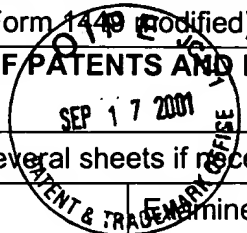
Foreign Patent Documents								
*Examiner Initial		Document Number	Date	Country	Class	Subclass	Translation	
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	B1	0 660 499 A1	06/28/1995	EP	H02N	13/00	<input type="checkbox"/>	<input type="checkbox"/>
	B2	0 668 608 A1	08/23/1995	EP	H01L	21/00	<input type="checkbox"/>	<input type="checkbox"/>
	B3	0 697 467 A1	02/21/1996	EP	C23C	16/44	<input type="checkbox"/>	<input type="checkbox"/>
	B4	2.171.877	09/28/1972	FR	C23C	11/00	<input checked="" type="checkbox"/>	<input type="checkbox"/>

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	C1	USSN 08/865,267, dated May 29, 1997
	C2	USSN 08/712,724, dated September 11, 1996
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(PTO Form 1449 modified)		APPM/1570.01	09/912,112
LIST OF PATENTS AND PUBLICATIONS CITED BY APPLICANT		Applicant Ishikawa, et al.	Confirmation No.:
(Use several sheets if necessary)		Filing Date	Group
Examiner Unknown		July 23, 2001	Unknown



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*Examiner Initial		Document Number	Issue Date	Applicant(s) Name	Class	Subclass	Filing Date If Appropriate
	A14	5,618,382	04/08/1997	Mintz, et al.	216	64	06/25/1993
	A15	5,614,055	03/25/1997	Fairbairn, et al.	156	345	08/27/1993
	A16	5,597,439	01/28/1997	Salzman	156	345	10/26/1994
	A17	5,587,344	12/24/1996	Ishikawa	437	238	04/26/1995
	A18	5,556,501	09/17/1996	Collins, et al.	156	345	04/01/1993
	A19	5,554,223	09/10/1996	Imahashi	118	723	03/04/1994
	A20	5,545,591	08/13/1996	Sugai, et al.	437	192	11/06/1995
	A21	5,540,800	07/30/1996	Qian	156	345	06/23/1994
	A22	5,537,004	07/16/1996	Imahashi, et al.	315	111.21	04/29/1994
	A23	5,534,231	07/09/1996	Savas	216	67	01/17/1995
	A24	5,525,159	06/11/1996	Hama, et al.	118	723 I	12/16/1994

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*Examiner Initial		Document Number	Date	Country	Class	Subclass	Translation	
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	B5	03-076,112 (Abst)	02/04/1991	JP	H01L	21/205	<input checked="" type="checkbox"/>	<input type="checkbox"/>
	B6	06-280,000 (Abst)	04/10/1996	JP	C23C	14/22	<input checked="" type="checkbox"/>	<input type="checkbox"/>
	B7	07-161,695 (Abst)	06/23/1995	JP	H01L	21/3065	<input checked="" type="checkbox"/>	<input type="checkbox"/>
	B8	61-064124 (Abst)	02/04/1986	JP	H01L	21/205	<input checked="" type="checkbox"/>	<input type="checkbox"/>

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*Examiner Initial		Including Author, Title, Date, Pertinent Pages, Etc.
	C3	USSN 08/574,839, dated December 19, 1995
	C4	Lucovsky, et al., "Deposition of silicon dioxide and silicon nitride by remote plasma enhanced chemical vapor deposition", <i>J. Vac. Sci. & Tech.</i> , Vol.4, No. 3, Part I (May-June 1968), pp. 681-688

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U.S. Department of Commerce, Patent and Trademark Office		Docket No. SEP 17 2001	Serial No.
(PTO Form 1449 modified)		APPM/1570.C18	09/912,112
LIST OF PATENTS AND PUBLICATIONS CITED BY APPLICANT		Applicant	Confirmation No.:
(Use several sheets if necessary)		Ishikawa, et al.	
Examiner Unknown		Filing Date	Group
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*Examiner Initial		Document Number	Issue Date	Applicant(s) Name	Class	Subclass	Filing Date If Appropriate
	A25	5,522,937	06/04/937	Chew, et al.	118	728	05/03/1994
	A26	5,449,432	09/12/1995	Hanawa	156	643.1	10/25/1993
	A27	5,401,350	03/28/1995	Patrick, et al.	156	345	03/08/1993
	A28	5,389,154	02/14/1995	Hiroshi, et al.	118	723 MR	06/24/1993
	A29	5,378,311	01/03/1995	Nagayama, et al.	156	643	11/24/1993
	A30	5,376,628	12/27/1994	Sekiguchi, et al.	505	480	03/09/1992
	A31	5,365,057	11/15/1994	Morley, et al.	250	214 VT	07/02/1993
	A32	5,330,610	07/19/1994	Eres, et al.	117	86	05/28/1993
	A33	5,314,845	05/24/1994	Lee, et al.	437	238	02/02/1990
	A34	5,310,452	05/10/1994	Doki, et al.	156	643	07/20/1992
	A35	5,234,529	08/10/1993	Johnson	156	345	10/10/1991
	A36	5,223,457	06/29/1993	Mintz, et al.	437	225	10/11/1991
	A37	5,200,232	04/06/1993	Tappan, et al.	427	569	12/11/1990

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	B9	63-292,625 (Abst)	11/29/1988	JP	H01L	21/302	<input checked="" type="checkbox"/>	<input type="checkbox"/>
	B10	01-276736 (Abst)	07/11/1989	JP	H01L	21/68	<input checked="" type="checkbox"/>	<input type="checkbox"/>
	B11	02-271626 (Abst)	06/11/1990	JP	H01L	21/31	<input checked="" type="checkbox"/>	<input type="checkbox"/>
	B12	97/03224	01/30/1997	WO	C23C	16/00	<input type="checkbox"/>	<input type="checkbox"/>

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LIST OF PATENTS AND PUBLICATIONS CITED BY APPLICANT		Applicant	Confirmation
(Use several sheets if necessary)		Ishikawa, et al.	No.:
Examiner Unknown		Filing Date	Group
		July 23, 2001	Unknown

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	A38	5,124,014	06/23/1992	Foo, et al.	204	192.32	04/11/1991
	A39	5,122,251	06/16/1992	Campbell, et al.	204	298.06	02/04/1991
	A40	5,105,761	04/21/1992	Charlet, et al.	118	723	10/15/1990
	A41	5,091,049	02/25/1992	Campbell, et al.	156	643	06/29/1990
	A42	5,000,113	03/19/1991	Wang, et al.	118	723	12/19/1986
	A43	4,990,229	02/05/1991	Campbell, et al.	204	298.06	06/13/1989
	A44	4,986,890	01/22/1991	Setoyama. Et al.	204	298.06	04/24/1990
	A45	4,975,252	12/04/1990	Nishizawa, et al.	422	245	05/26/1989
	A46	4,960,488	10/02/1990	Law, et al.	156	643	12/19/1989
	A47	4,949,671	08/21/1990	Davis, et al.	118	725	12/21/1985
	A48	4,918,031	04/17/1990	Flamm, et al.	437	225	12/28/1988
	A49	4,876,983	10/31/1989	Fukuda, et al.	118	722	01/19/1988
	A50	4,848,273	07/18/1989	Mori, et al.	118	729	09/01/1987

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Examiner Unknown		Confirmation No.:	

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	A51	4,828,369	05/09/1989	Hotomi	350	357	05/27/1987
	A52	4,798,165	01/17/1989	DeBoer, et al.	118	715	01/25/1988
	A53	4,795,529	01/03/1989	Kawasaki, et al.	156	643	10/19/1987
	A54	4,771,730	09/20/1988	Tezuka, et al.	118	723	09/09/1987
	A55	4,724,621	02/16/1988	Hobson, et al.	34	218	04/17/1986
	A56	4,565,601	01/21/1986	Kakehi, et al.	156	643	11/28/1984
	A57	4,558,388	12/10/1985	Graves, Jr., et al.	360	135	11/02/1983
	A58	4,512,283	04/23/1985	Bonifield, et al.	118	723	11/04/1983
	A59	3,656,454	04/18/1972	Schrader	118	49	11/23/1970

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